

DS26C32AT/DS26C32AM Quad Differential Line Receiver

Check for Samples: DS26C32AM, DS26C32AT

FEATURES

- CMOS Design for Low Power
- ±0.2V Sensitivity over Input Common Mode Voltage Range
- Typical Propagation Delays: 19 ns
- Typical Input hysteresis: 60 mV
- Inputs Won't Load Line When V_{CC} = 0V
- Meets the Requirements of EIA Standard RS-422
- TRI-STATE Outputs for Connection to System Buses
- Available in Surface Mount
- Mil-Std-883C Compliant

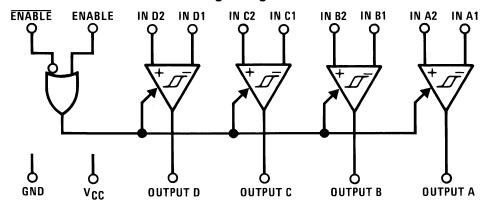
DESCRIPTION

The DS26C32A is a quad differential line receiver designed to meet the RS-422, RS-423, and Federal Standards 1020 and 1030 for balanced and unbalanced digital data transmission, while retaining the low power characteristics of CMOS.

The DS26C32A has an input sensitivity of 200 mV over the common mode input voltage range of ±7V. The DS26C32A features internal pull-up and pull-down resistors which prevent output oscillation on unused channels.

The DS26C32A provides an enable and disable function common to all four receivers. It also features TRI-STATE outputs with 6 mA source and sink capability. This product is pin compatible with the DS26LS32A and the AM26LS32.

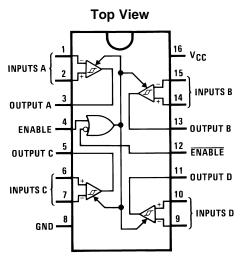
Logic Diagram



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



Connection Diagrams



For Complete Military Product Specifications, refer to the appropriate SMD or MDS.

Figure 1. PDIP Package See Package Number D0016A or NFG0016E See Package Number NAJ0020A, NFE0016A or NAD0016A

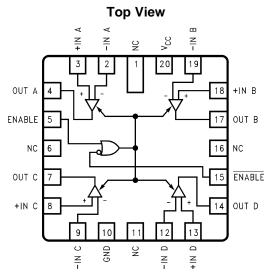


Figure 2. 20-Lead Ceramic Leadless Chip Carrier LCCC Package



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

www.ti.com

Absolute Maximum Ratings (1)(2)(3)

	<u></u>
Supply Voltage (V _{CC})	7V
Common Mode Range (V _{CM})	±14V
Differential Input Voltage (V _{DIFF})	±14V
Enable Input Voltage (V IN)	7V
Storage Temperature Range (T _{STG})	−65°C to +150°C
Lead Temperature (Soldering 4 sec.)	260°C
Maximum Power Dissipation at 25°C (4)	
Ceramic NFE0016A Package	2308 mW
Plastic NFG0016E Package	1645 mW
SOIC D0016A Package	1190 mW
Ceramic NAJ0020A Package	2108 mW
Ceramic NAD0016A Package	1215 mW
Maximum Current Per Output	±25 mA
This device does not meet 2000V ESD rating. (5)	

- (1) Absolute Maximum Ratings are those values beyond which the safety of the device cannot be ensured. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.
- (2) Unless otherwise specified, all voltages are referenced to ground.
- (3) If Military/Aerospace specified devices are required, please contact the TI Sales Office/Distributors for availability and specifications
- (4) Ratings apply to ambient temperature at 25°C. Above this temperature derate N Package 13.16 mW/°C, J Package 15.38 mW/°C, M Package 9.52 mW/°C, E Package 12.04 mW/°C, and W package 6.94 mW/°C.
- (5) ESD Rating: HBM (1.5 kΩ, 100 pF) Inputs ≥2000V All other pins ≥1000V EIAJ (0Ω, 200 pF) ≥350V

Operating Conditions

	Min	Max	Units
Supply Voltage (V _{CC})	4.50	5.50	V
Operating Temperature Range (T _A)			
DS26C32AT	-40	+85	°C
DS26C32AM	-55	+125	°C
Enable Input Rise or Fall Times		500	ns

DC Electrical Characteristics

 $V_{CC} = 5V \pm 10\%$ (unless otherwise specified)⁽¹⁾

	Parameter	Test Condit	ions	Min	Тур	Max	Units
V _{TH}	Minimum Differential Input Voltage	$V_{OUT} = V_{OH} \text{ or } V_{OL}$ -7V < V_{CM} < +7V		-200	35	+200	mV
R _{IN}	Input Resistance	$V_{IN} = -7V$, $+7V$	DS26C32AT	5.0	6.8	10	kΩ
		(Other Input = GND)	DS26C32AM	4.5	6.8	11	kΩ
I _{IN}	Input Current	$V_{IN} = +10V$,	DS26C32AT		+1.1	+1.5	mA
		Other Input = GND	DS26C32AM		+1.1	+1.8	mA
		V _{IN} = −10V,	DS26C32AT		-2.0	-2.5	mA
		Other Input = GND	DS26C32AM		-2.0	-2.7	mA
V _{OH}	Minimum High Level	V _{CC} = Min, V _{DIFF} = +1V	3.8	4.2		V	
	Output Voltage	I _{OUT} = −6.0 mA					
V _{OL}	Maximum Low Level	$V_{CC} = Max, V_{DIFF} = -1V$			0.2	0.3	V
	Output Voltage	I _{OUT} = 6.0 mA					
V _{IH}	Minimum Enable High Input Level Voltage			2.0			V
V _{IL}	Maximum Enable Low Input Level Voltage					0.8	V

⁽¹⁾ Absolute Maximum Ratings are those values beyond which the safety of the device cannot be ensured. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.



DC Electrical Characteristics (continued)

 $V_{CC} = 5V \pm 10\%$ (unless otherwise specified)⁽¹⁾

	Parameter	Test Condi	tions	Min	Тур	Max	Units
l _{OZ}	Maximum TRI-STATE Output Leakage Current	$V_{OUT} = V_{CC}$ or GND, $ENABLE = V_{IL}$, $ENABLE = V_{IH}$			±0.5	±5.0	μА
l _l	Maximum Enable Input Current	V _{IN} = V _{CC} or GND				±1.0	μΑ
I _{CC}	Quiescent Power	V _{CC} = Max,	DS26C32AT		16	23	mA
Supply Current		$V_{DIF} = +1V$		16	25	mA	
V _{HYST}	Input Hysteresis	V _{CM} = 0V			60		mV

AC Electrical Characteristics

 $V_{CC} = 5V \pm 10\%$ (1)

	Danamatan	Toot Conditions	N4:	T	М	ax	l luita	
	Parameter	Test Conditions	Min	Тур	DS26C32AT	DS26C32AM	Units	
t _{PLH} ,	Propagation Delay	C _L = 50 pF	10	19	30	35	ns	
t _{PHL}	Input to Output	V _{DIFF} = 2.5V						
		V _{CM} = 0V	V _{CM} = 0V					
t _{RISE} , Output Rise and		C _L = 50 pF		4	9	9	ns	
t _{FALL}	Fall Times	V _{DIFF} = 2.5V						
		V _{CM} = 0V						
t _{PLZ} ,	Propagation Delay	C _L = 50 pF		13	22	29	ns	
t _{PHZ}	ENABLE to Output	$R_L = 1000\Omega$						
		V _{DIFF} = 2.5V						
t _{PZL} ,	Propagation Delay	C _L = 50 pF		13	23	29	ns	
t _{PZH}	ENABLE to Output	$R_L = 1000\Omega$						
		V _{DIFF} = 2.5V						

⁽¹⁾ Unless otherwise specified, Min/Max limits apply over recommended operating conditions. All typicals are given for $V_{CC} = 5V$ and $T_A = 25^{\circ}C$

Comparison Table of Switching Characteristics into "LS-Type" Load

(Figure 6, Figure 7, and Figure 8) (1)

	Parameter	Test Conditions	DS26C32A	DS26LS32A	Units	
	Farameter	Test Conditions	Тур	Тур	Oilles	
t _{PLH}	Input to Output	C _L = 15 pF	17	23	ns	
t _{PHL}			19	23	ns	
t_{LZ}	ENABLE to Output	$C_L = 5 pF$	13	15	ns	
t_{HZ}			12	20	ns	
t_{ZL}	ENABLE to Output	$C_L = 15 pF$	13	14	ns	
t_{ZH}			13	15	ns	

(1) This table is provided for comparison purposes only. The values in this table for the DS26C32A reflect the performance of the device, but are not tested.

Submit Documentation Feedback



TEST AND SWITCHING WAVEFORMS

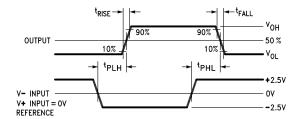
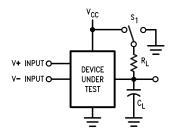


Figure 3. Propagation Delay



C_L includes load and test jig capacitance.

 $S_1 = V_{CC}$ for t _{PZL}, and t_{PLZ} measurements.

 S_1 = Gnd for t_{PZH} and t_{PHZ} measurements.

Figure 4. Test Circuit for TRI-STATE Output Tests

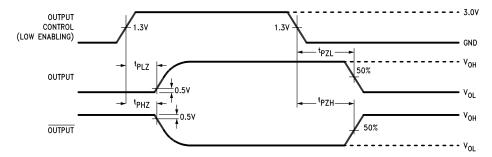


Figure 5. TRI-STATE Output Enable and Disable Waveforms

AC Test Circuit and Switching Time Waveforms

Copyright © 1998-2013, Texas Instruments Incorporated

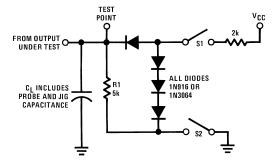


Figure 6. Load Test Circuit for TRI-STATE Outputs for "LS-Type" Load

Product Folder Links: DS26C32AM DS26C32AT



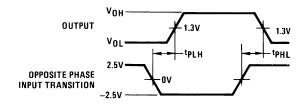
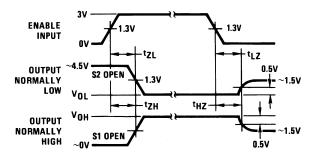


Figure 7. Propagation Delay for "LS-Type" Load



- (1) Diagram shown for ENABLE low.
- (2) S1 and S2 of load circuit are closed except where shown.
- (3) Pulse generator for all pulses: Rate \leq 1.0 MHz; $Z_O = 50\Omega$; $t_r \leq$ 15 ns; $t_f \leq$ 6.0 ns.

Figure 8. Enable and Disable Times for "LS-Type" Load

Truth Table⁽¹⁾

ENABLE	ENABLE	Input	Output	
L	L H X			
	Other	V _{ID} ≥ V _{TH} (Max)	Н	
	ations of Inputs	V _{ID} ≤ V _{TH} (Min)	L	
Ellabic	, inputo	Open	Н	

(1) Z = TRI-STATE

TYPICAL APPLICATIONS

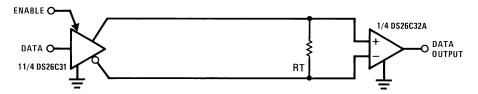
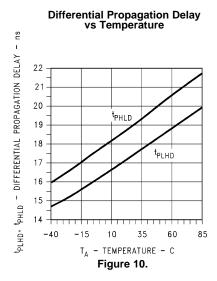


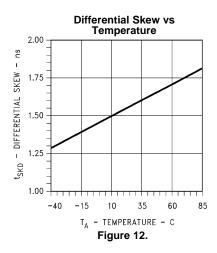
Figure 9. Two-Wire Balanced Systems, RS-422

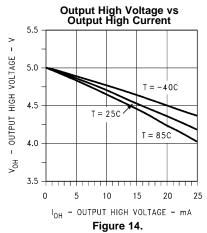
Submit Documentation Feedback

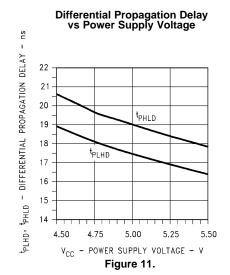


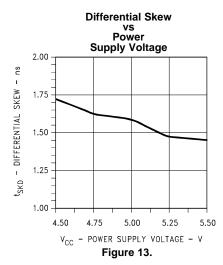
Typical Performance Characteristics

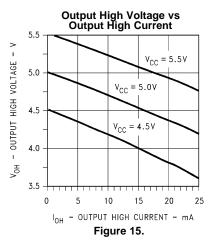






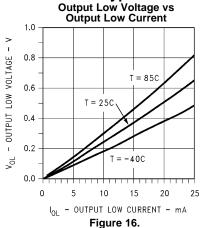


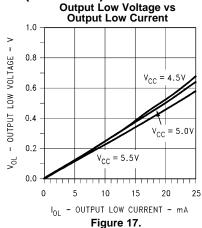


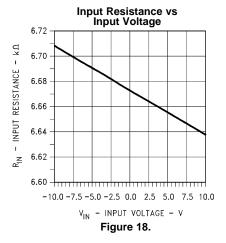


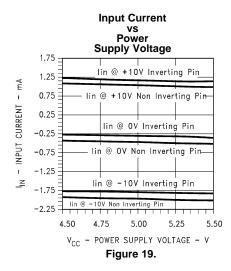


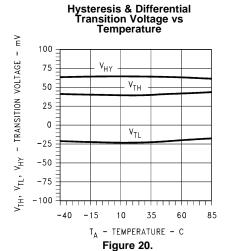
Typical Performance Characteristics (continued)

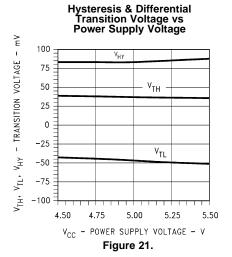






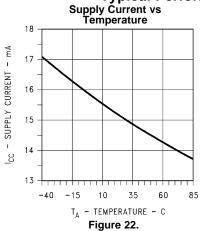


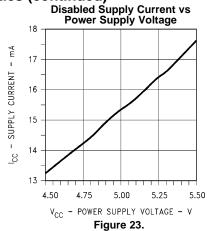


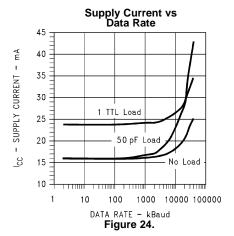




Typical Performance Characteristics (continued)











www.ti.com

REVISION HISTORY

Ch	nanges from Revision B (April 2013) to Revision C	Page)
•	Changed layout of National Data Sheet to TI format	9	9

Submit Documentation Feedback

Copyright © 1998–2013, Texas Instruments Incorporated

10



PACKAGE OPTION ADDENDUM

29-May-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
DS26C32ATM	NRND	SOIC	D	16	48	TBD	Call TI	Call TI	-40 to 85	DS26C32ATM	
DS26C32ATM/NOPB	ACTIVE	SOIC	D	16	48	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	DS26C32ATM	Samples
DS26C32ATMX	ACTIVE	SOIC	D	16	2500	TBD	Call TI	Call TI	-40 to 85	DS26C32ATM	Samples
DS26C32ATMX/NOPB	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	DS26C32ATM	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

29-May-2015

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 24-Apr-2013

TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

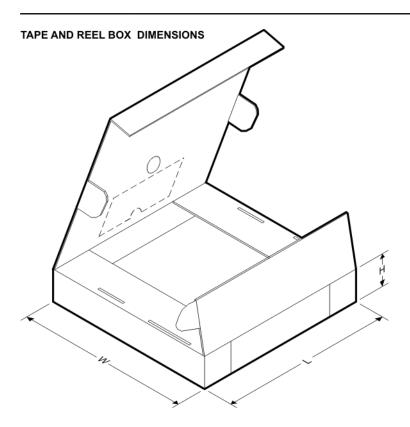
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS26C32ATMX	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.3	8.0	16.0	Q1
DS26C32ATMX/NOPB	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.3	8.0	16.0	Q1

www.ti.com 24-Apr-2013



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS26C32ATMX	SOIC	D	16	2500	367.0	367.0	35.0
DS26C32ATMX/NOPB	SOIC	D	16	2500	367.0	367.0	35.0

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive **Amplifiers** amplifier.ti.com Communications and Telecom www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps DSP dsp.ti.com **Energy and Lighting** www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical Logic Security www.ti.com/security logic.ti.com

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers <u>microcontroller.ti.com</u> Video and Imaging <u>www.ti.com/video</u>

RFID www.ti-rfid.com

OMAP Applications Processors www.ti.com/omap TI E2E Community e2e.ti.com

Wireless Connectivity www.ti.com/wirelessconnectivity